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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/685,080	AHMED ET AL.	
Examiner	Art Unit	
Tae H. Yoon	1714	

SEARCHED				
Class	Subclass	Date	Examiner	
523	130			
524	P32			
		441		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST	6-13-06	M		
Inventor Scard	6-15-06	7		
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